

<b>Notice of References Cited</b>	Application/Control No. 10/575,378		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner IYABO S. ALLI		Art Unit 2877	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,629,768	05-1997	Hagiwara, Tsuneyuki	356/237.5
*	B	US-6,727,512	04-2004	Stokowski et al.	250/559.45
*	C	US-6,654,113	11-2003	Fukazawa et al.	356/237.4
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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